

2SK2232-VB Datasheet N-Channel 60 V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	60					
$R_{DS(on)}\left(\Omega\right)$	V _{GS} = 10 V	0.027				
Q _g (Max.) (nC)	95					
Q _{gs} (nC)	27					
Q _{gd} (nC)	46					
Configuration	Single					

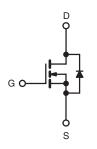
FEATURES

- · Isolated Package
- High Voltage Isolation = 2.5 kV_{RMS} (t = 60 s;



- Sink to Lead Creepage Distance = 4.8 mm
- 175 °C Operating Temperature
- Dynamic dV/dt Rating
- · Low Thermal Resistance
- Lead (Pb)-free Available





N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS $T_C = 25$ °C, unless otherwise noted **SYMBOL PARAMETER** LIMIT UNIT Drain-Source Voltage V_{DS} 60 V Gate-Source Voltage ± 20 V_{GS} $T_C = 25$ °C 45 V_{GS} at 10 V Continuous Drain Current I_D T_C = 100 °C Α 30 Pulsed Drain Current^a I_{DM} 220 Linear Derating Factor 0.32 W/°C Single Pulse Avalanche Energyb E_{AS} 100 mJ $T_C = 25 \, ^{\circ}C$ Maximum Power Dissipation 52 W P_{D} Peak Diode Recovery dV/dtc dV/dt V/ns 4.5 Operating Junction and Storage Temperature Range T_J, T_{stg} - 55 to + 175 °C Soldering Recommendations (Peak Temperature) for 10 s 300^d 10 lbf ⋅ in Mounting Torque 6-32 or M3 screw $N \cdot m$ 1.1

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. V_{DD} = 25 V, starting T_J = 25 °C, L = 129 μ H, R_G = 25 Ω , I_{AS} = 30 A (see fig. 12). c. $I_{SD} \le 52$ A, $dI/dt \le 250$ A/ μ s, $V_{DD} \le V_{DS}$, $T_J \le 175$ °C.
- d. 1.6 mm from case.



THERMAL RESISTANCE RATINGS							
PARAMETER	SYMBOL	TYP.	MAX.	UNIT			
Maximum Junction-to-Ambient	R _{thJA}	-	65	°C/W			
Maximum Junction-to-Case (Drain)	R _{thJC}	-	3.1	C/VV			

PARAMETER	SYMBOL	TES	MIN.	TYP.	MAX.	UNIT		
Static								
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} :	60	-	-	V		
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference to 25 °C, I _D = 1 mA		-	0.060	-	V/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$		1.0	-	3.0	V	
Gate-Source Leakage	I _{GSS}	V _{GS} = ± 20 V		-	-	± 100	nA	
Zana Cata Valtana Darin Commit	I _{DSS}	V _{DS} :	V _{DS} = 60 V, V _{GS} = 0 V		-	25		
Zero Gate Voltage Drain Current		V _{DS} = 48 V	, V _{GS} = 0 V, T _J = 150 °C	-	-	250	μΑ	
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 18 A ^b	-	0.027	-	Ω	
Forward Transconductance	9 _{fs}	$V_{DS} = 25 \text{ V}, I_D = 18 \text{ Ab}$		15	-	-	S	
Dynamic								
Input Capacitance	C _{iss}	$V_{GS} = 0 V$,		-	1500	-		
Output Capacitance	C _{oss}	1	$V_{DS} = 25 \text{ V},$		720	-		
Reverse Transfer Capacitance	C _{rss}	f = 1.0 MHz, see fig. 5		-	100	-	pF	
Drain to Sink Capacitance	С	f = 1.0 MHz		-	12	-	1	
Total Gate Charge	Qg		I _D = 52 A, V _{DS} = 48 V, see fig. 6 and 13 ^b	-	-	95	nC	
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V		-	-	27		
Gate-Drain Charge	Q _{gd}			-	-	46		
Turn-On Delay Time	t _{d(on)}	$V_{DD} = 30 \text{ V}, I_D = 52 \text{ A},$ $R_G = 9.1 \Omega, R_D = 0.54 \Omega,$ see fig. 10^b		-	19	-	- ns	
Rise Time	t _r			-	120	-		
Turn-Off Delay Time	t _{d(off)}			-	55	-		
Fall Time	t _f			-	86	-		
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	- nH	
Internal Source Inductance	L _S			-	7.5	-		
Drain-Source Body Diode Characteristic	s						•	
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	45	- A	
Pulsed Diode Forward Current ^a	I _{SM}			-	-	120		
Body Diode Voltage	V_{SD}	T _J = 25 °C	$T_J = 25 ^{\circ}\text{C}, I_S = 30 \text{A}, V_{GS} = 0 \text{V}^{\text{b}}$		-	2.5	V	
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = 52 A, dl/dt = 100 A/μs ^b		_	140	300	ns	
Body Diode Reverse Recovery Charge	Q _{rr}			-	1.2	2.8	μС	
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L _S and L _D)						

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width \leq 300 μ s; duty cycle \leq 2 %.



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

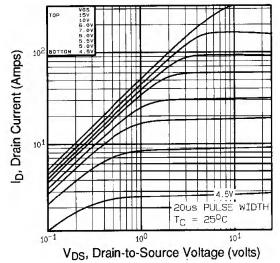


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

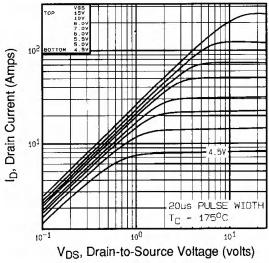


Fig. 2 - Typical Output Characteristics, T_C = 175 °C

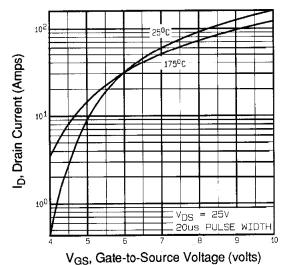


Fig. 3 - Typical Transfer Characteristics

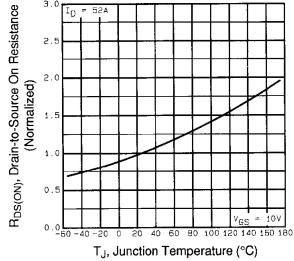


Fig. 4 - Normalized On-Resistance vs. Temperature



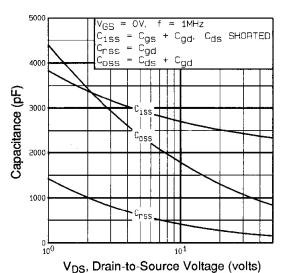


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

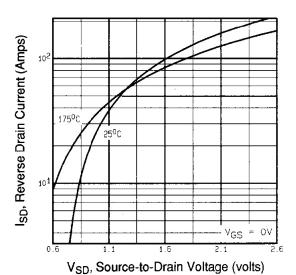


Fig. 7 - Typical Source-Drain Diode Forward Voltage

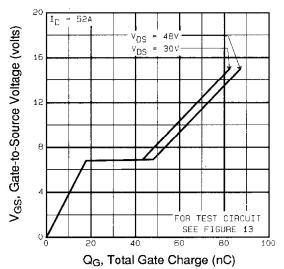
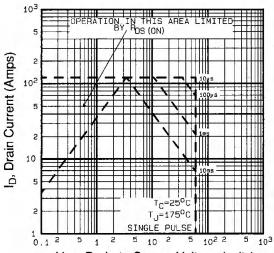


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage



V_{DS}, Drain-to-Source Voltage (volts) Fig. 8 - Maximum Safe Operating Area



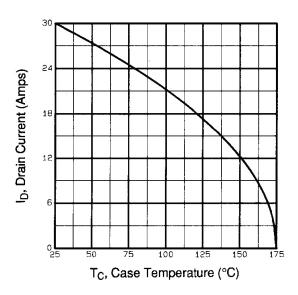


Fig. 9 - Maximum Drain Current vs. Case Temperature

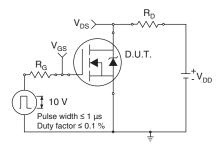


Fig. 10a - Switching Time Test Circuit

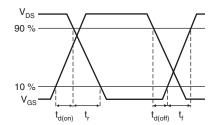


Fig. 10b - Switching Time Waveforms

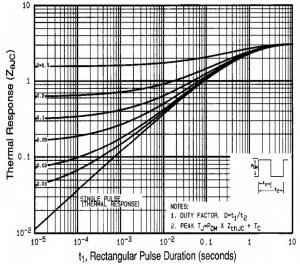


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

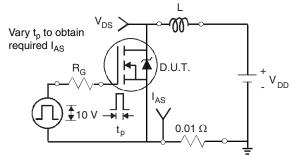


Fig. 12a - Unclamped Inductive Test Circuit

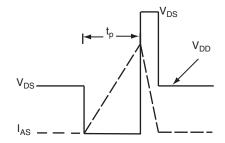
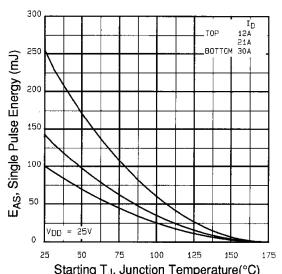


Fig. 12b - Unclamped Inductive Waveforms





 $Starting \ T_J, \ Junction \ Temperature (^{\circ}C)$ Fig. 12c - Maximum Avalanche Energy vs. Drain Current

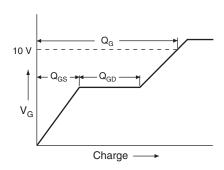


Fig. 13a - Basic Gate Charge Waveform

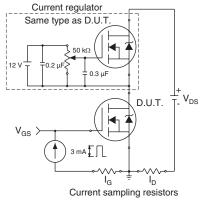
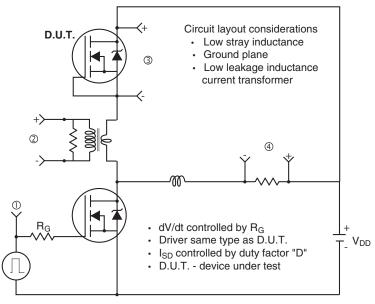
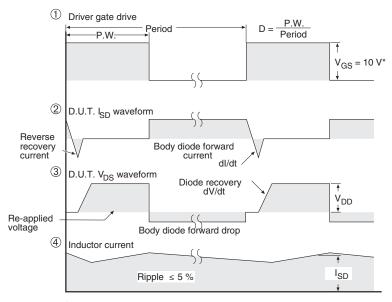


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit





* $V_{GS} = 5 V$ for logic level devices

Fig. 14 - For N-Channel



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